

2 x 210 Watt STEREO DIGITAL AMPLIFIER POWER STAGE

FEATURES

- 2×160 W at 10% THD+N Into 8-Ω BTL
- 2×210 W at 10% THD+N Into 6-Ω BTL
- 1×300 W at 10% THD+N Into 4-Ω PBTL ⁽¹⁾
- >110 dB SNR (A-Weighted, TAS5518 Modulator)
- <0.09% THD+N at 1 W
- Two Thermally Enhanced Package Options:
 - DKD (36-pin PSOP3)
 - DDV (44-pin HTSSOP)
- High-Efficiency Power Stage (>90%) With 80-mΩ Output MOSFETs
- Power-On Reset for Protection on Power Up Without Any Power-Supply Sequencing
- Integrated Self-Protection Circuits Including Undervoltage, Overtemperature, Overload, Short Circuit
- Error Reporting
- EMI Compliant When Used With Recommended System Design
- Intelligent Gate Drive
- Mid-Z Ramp Compatible for reduced "pop noise"

APPLICATIONS

- Mini/Micro Audio System
- DVD Receiver
- Home Theater

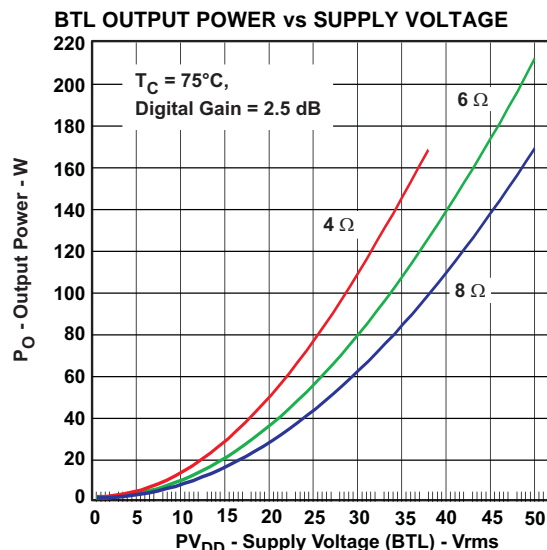
DESCRIPTION

The TAS5162 is a high performance, integrated stereo digital amplifier power stage with an improved protection system. The TAS5162 is capable of driving a 6-Ω bridge-tied load (BTL) at up to 210 W per channel at THD = 10%, low integrated noise at the output, low THD+N performance without clipping, and low idle power dissipation.

A low-cost, high-fidelity audio system can be built using a TI chipset, comprising a modulator (e.g., TAS5508) and the TAS5162.

This system only requires a simple passive LC demodulation filter to deliver high-quality, high-efficiency audio amplification with proven EMI compliance. This device requires two power supplies, at 12 V for GVDD and VDD, and at 50V for PVDD. The TAS5162 does not require power-up sequencing due to internal power-on reset. The efficiency of this digital amplifier is greater than 90% into 6 Ω, which enables the use of smaller power supplies and heatsinks.

The TAS5162 has an innovative protection system integrated on-chip, safeguarding the device against a wide range of fault conditions that could damage the system. These safeguards are short-circuit protection, overcurrent protection, undervoltage protection, and overtemperature protection. The TAS5162 has a new proprietary current-limiting circuit that reduces the possibility of device shutdown during high-level music transients. A new programmable overcurrent detector allows the use of lower-cost inductors in the demodulation output filter.



- (1) The DDV package will deliver the stated maximum power levels; however, this is dependant on system configuration. The smaller pad area also makes the thermal interface to the heatsink more important. For multichannel systems that require two channels to be driven at full power with the DDV package option, it is recommended to design the system so that the two channels are in two separate devices.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PurePath Digital, PowerPad are trademarks of Texas Instruments.
All other trademarks are the property of their respective owners.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

GENERAL INFORMATION

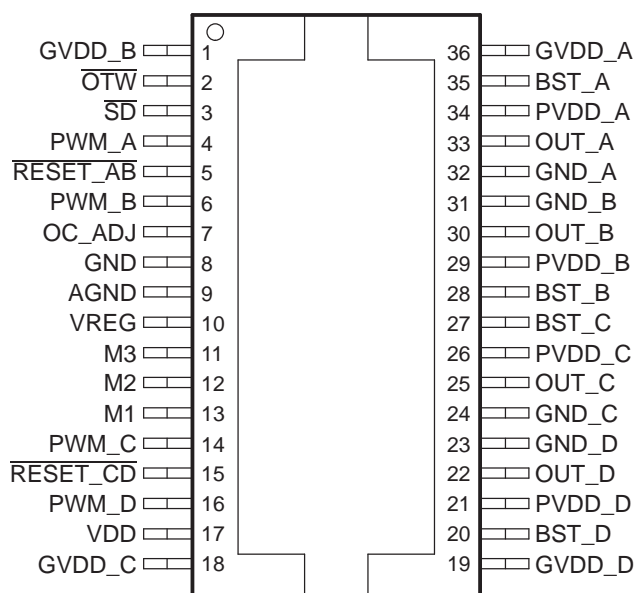
Terminal Assignment

The TAS5162 is available in two thermally enhanced packages:

- 36-pin PSOP3 package (DKD)
- 44-pin HTSSOP PowerPad™ package (DDV)

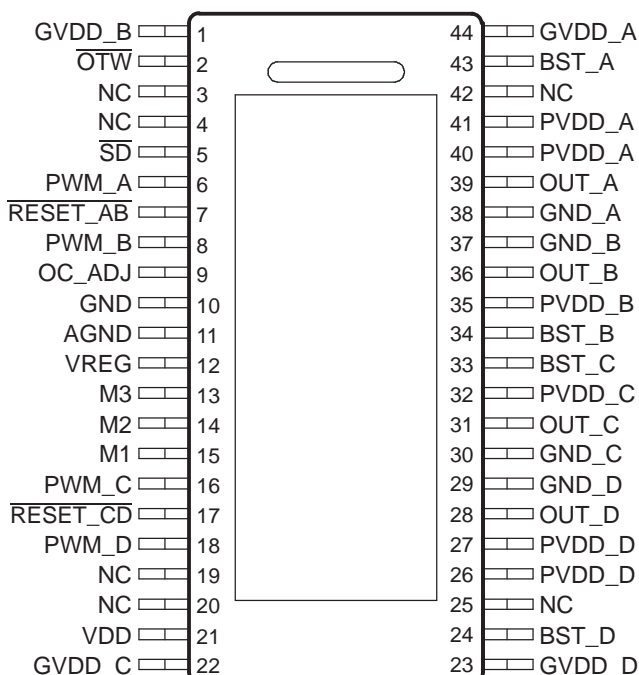
Both package types contain a heat slug that is located on the top side of the device for convenient thermal coupling to the heatsink.

**DKD PACKAGE
(TOP VIEW)**



P0018-01

**DDV PACKAGE
(TOP VIEW)**



P0016-02

GENERAL INFORMATION (continued)

MODE Selection Pins for Both Packages

MODE PINS			PWM INPUT	OUTPUT CONFIGURATION	PROTECTION SCHEME
M3	M2	M1			
0	0	0	2N ⁽¹⁾ AD/BD modulation	2 channels BTL output	BTL mode, full protection ⁽²⁾
0	0	1	2N ⁽¹⁾ AD/BD modulation	2 channels BTL output	BTL mode, latching shutdown ⁽²⁾
0	1	0	1N ⁽¹⁾ AD modulation	2 channels BTL output	BTL mode, full protection ⁽²⁾
0	1	1	1N ⁽¹⁾ AD modulation	1 channel PBTL output	PBTL mode, full protection. Only PWM_A input is used.
1	0	0	1N ⁽¹⁾ AD modulation	4 channels SE output	Protection works similarly to BTL mode ⁽²⁾ . Only difference in SE mode is that OUT_X is Hi-Z instead of a pulldown through internal pulldown resistor.
1	0	1	1N ⁽¹⁾ AD modulation	4 channels SE output - No PWM Input protection, latching shutdown	Protection works similarly to SE Mode ⁽²⁾ (1,0,0); however, the PWM input protection is disabled. Also, overcurrent detection will latch if an error occurs.
1	1	0	Reserved		
1	1	1			

- (1) The 1N and 2N naming convention is used to indicate the required number of PWM lines to the power stage per channel in a specific mode.
- (2) An overload protection (OLP) occurring on A or B causes both channels to shut down. An OLP on C or D works similarly. Global errors like overtemperature error (OTE), undervoltage protection (UVP), and power-on reset (POR) affect all channels.

Package Heat Dissipation Ratings⁽¹⁾

PARAMETER	TAS5162DKD	TAS5162DDV
R _{θJC} (°C/W)—2 BTL or 4 SE channels (8 transistors)	1.0	1.1
R _{θJC} (°C/W)—1 BTL or 2 SE channel(s) (4 transistors)	1.5	2.2
R _{θJC} (°C/W)—(1 transistor)	5.0	7.4
Pad area ⁽²⁾	80 mm ²	34 mm ²

- (1) JC is junction-to-case, CH is case-to-heatsink.
- (2) R_{θCH} is an important consideration. Assume a 2-mil thickness of typical thermal grease between the pad area and the heatsink and both channels active. The R_{θCH} with this condition is 2.6°C/W for the DKD package and 4.0°C/W for the DDV package.

ABSOLUTE MAXIMUM RATINGSover operating free-air temperature range unless otherwise noted ⁽¹⁾

TAS5162	
VDD to AGND	–0.3 V to 13.2 V
GVDD_X to AGND	–0.3 V to 13.2 V
PVDD_X to GND_X ⁽²⁾	–0.3 V to 71 V
OUT_X to GND_X ⁽²⁾	–0.3 V to 71V
BST_X to GND_X ⁽²⁾	–0.3 V to 79.7 V
VREG to AGND	–0.3 V to 4.2 V
GND_X to GND	–0.3 V to 0.3 V
GND_X to AGND	–0.3 V to 0.3 V
GND to AGND	–0.3 V to 0.3 V
PWM_X, OC_ADJ, M1, M2, M3 to AGND	–0.3 V to 4.2 V
RESET_X, SD, OTW to AGND	–0.3 V to 7 V
Maximum continuous sink current (SD, OTW)	9 mA
Maximum operating junction temperature range, T _J	0°C to 125°C
Storage temperature	–40°C to 125°C
Lead temperature, 1,6 mm (1/16 inch) from case for 10 seconds	260°C
Minimum pulse duration, low	50 ns

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) These voltages represent the dc voltage + peak ac waveform measured at the terminal of the device in all conditions.

ORDERING INFORMATION

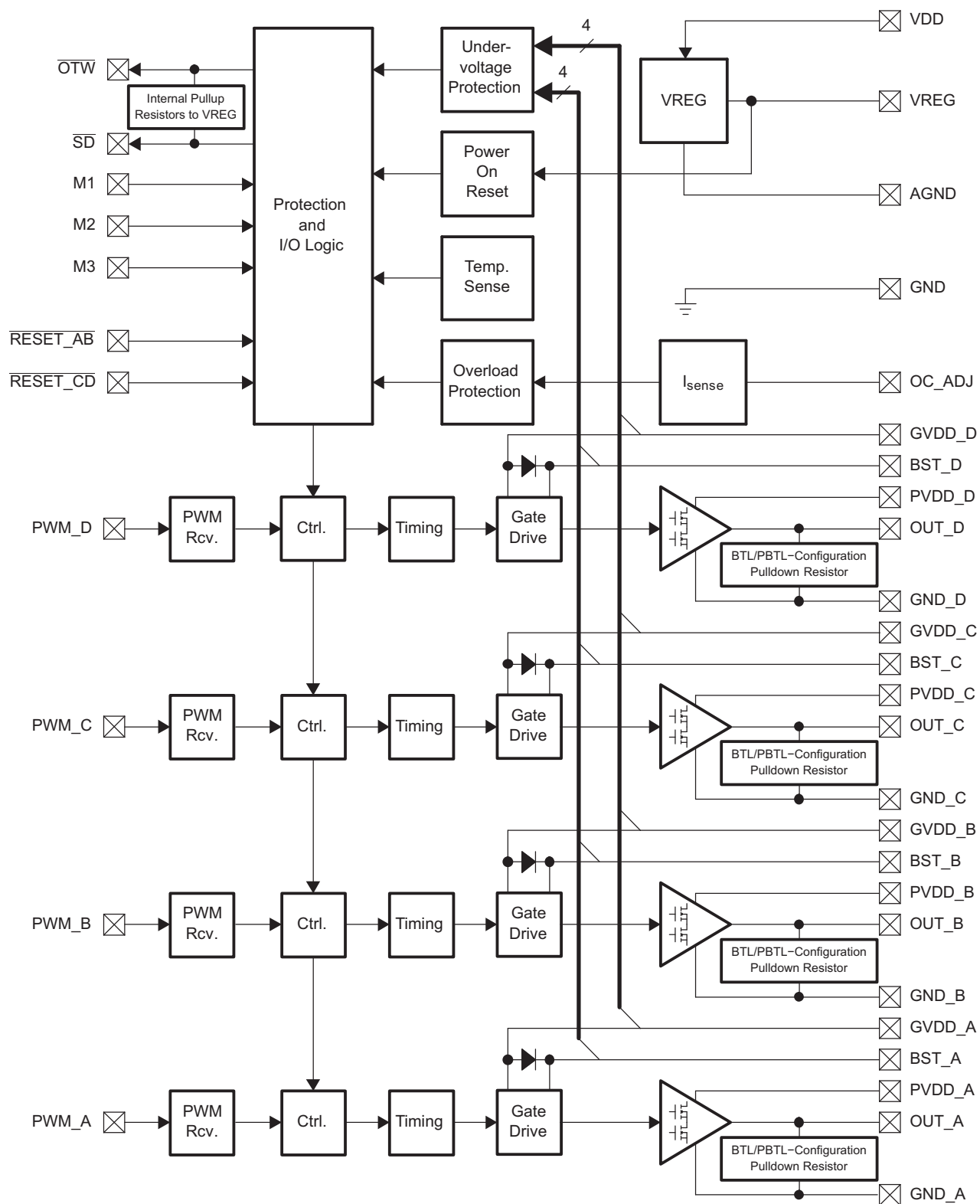
T_A	PACKAGE	DESCRIPTION
0°C to 70°C	TAS5162DKD	36-pin PSOP3
0°C to 70°C	TAS5162DDV	44-pin HTSSOP

For the most current specification and package information, see the TI Web site at www.ti.com.

Terminal Functions

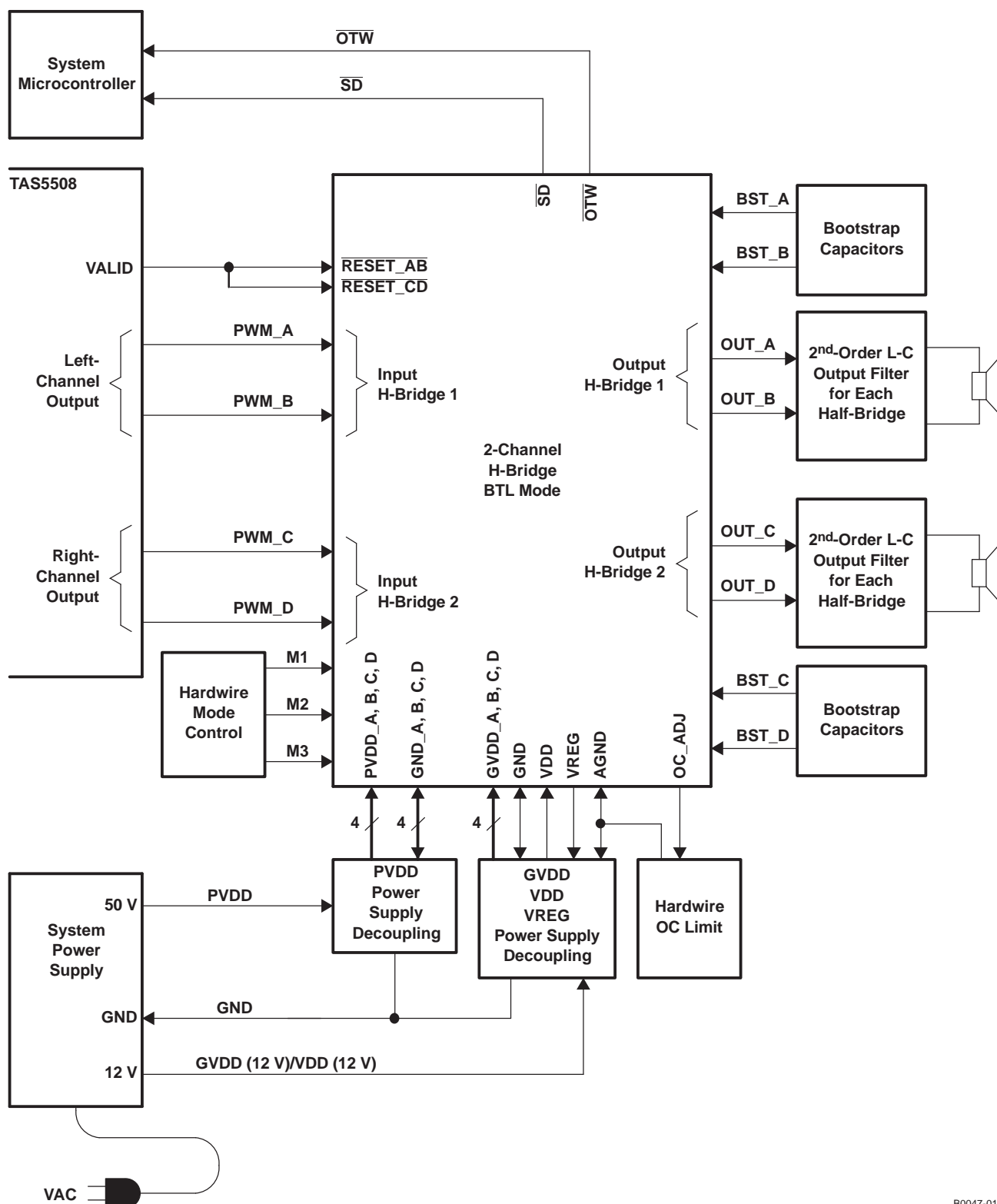
TERMINAL			FUNCTION ⁽¹⁾	DESCRIPTION
NAME	DKD NO.	DDV NO.		
AGND	9	11	P	Analog ground
BST_A	35	43	P	HS bootstrap supply (BST), external .033-μF capacitor to OUT_A required
BST_B	28	34	P	HS bootstrap supply (BST), external .033-μF capacitor to OUT_B required
BST_C	27	33	P	HS bootstrap supply (BST), external .033-μF capacitor to OUT_C required
BST_D	20	24	P	HS bootstrap supply (BST), external .033-μF capacitor to OUT_D required
GND	8	10	P	Ground
GND_A	32	38	P	Power ground for half-bridge A
GND_B	31	37	P	Power ground for half-bridge B
GND_C	24	30	P	Power ground for half-bridge C
GND_D	23	29	P	Power ground for half-bridge D
GVDD_A	36	44	P	Gate-drive voltage supply requires 0.1-μF capacitor to AGND
GVDD_B	1	1	P	Gate-drive voltage supply requires 0.1-μF capacitor to AGND
GVDD_C	18	22	P	Gate-drive voltage supply requires 0.1-μF capacitor to AGND
GVDD_D	19	23	P	Gate-drive voltage supply requires 0.1-μF capacitor to AGND
M1	13	15	I	Mode selection pin
M2	12	14	I	Mode selection pin
M3	11	13	I	Mode selection pin
NC	–	3, 4, 19, 20, 25, 42	–	No connect. Pins may be grounded.
OC_ADJ	7	9	O	Analog overcurrent programming pin requires resistor to ground
OTW	2	2	O	Overtemperature warning signal, open-drain, active-low
OUT_A	33	39	O	Output, half-bridge A
OUT_B	30	36	O	Output, half-bridge B
OUT_C	25	31	O	Output, half-bridge C
OUT_D	22	28	O	Output, half-bridge D
PVDD_A	34	40, 41	P	Power supply input for half-bridge A requires close decoupling of 0.01-μF capacitor in parallel with a 1.0-μF capacitor to GND_A.
PVDD_B	29	35	P	Power supply input for half-bridge B requires close decoupling of 0.01-μF capacitor in parallel with a 1.0-μF capacitor to GND_B.
PVDD_C	26	32	P	Power supply input for half-bridge C requires close decoupling of 0.01-μF capacitor in parallel with a 1.0-μF capacitor to GND_C.
PVDD_D	21	26, 27	P	Power supply input for half-bridge D requires close decoupling of 0.01-μF capacitor in parallel with a 1.0-μF capacitor to GND_D.
PWM_A	4	6	I	Input signal for half-bridge A
PWM_B	6	8	I	Input signal for half-bridge B
PWM_C	14	16	I	Input signal for half-bridge C
PWM_D	16	18	I	Input signal for half-bridge D
RESET_AB	5	7	I	Reset signal for half-bridge A and half-bridge B, active-low
RESET_CD	15	17	I	Reset signal for half-bridge C and half-bridge D, active-low
SD	3	5	O	Shutdown signal, open-drain, active-low
VDD	17	21	P	Power supply for digital voltage regulator requires a 47-μF capacitor in parallel with a 0.1-μF capacitor to GND for decoupling.
VREG	10	12	P	Digital regulator supply filter pin requires 0.1-μF capacitor to AGND.

(1) I = input, O = output, P = power

SYSTEM BLOCK DIAGRAM

B0034-03

FUNCTIONAL BLOCK DIAGRAM



B0047-01

RECOMMENDED OPERATING CONDITIONS

			MIN	TYP	MAX	UNIT
PVDD_X	Half-bridge supply	DC supply voltage	0	50	52.5	V
GVDD_X	Supply for logic regulators and gate-drive circuitry	DC supply voltage	10.8	12	13.2	V
VDD	Digital regulator input	DC supply voltage	10.8	12	13.2	V
R _L (BTL)	Load impedance	Output filter: L = 10 μ H, C = 470 nF. Output AD modulation, switching frequency > 350 kHz	4.6	6-8		Ω
R _L (SE)			2.5	3-8		
R _L (PBTl)				4-8		
L _{Output} (BTL)	Output-filter inductance	Minimum output inductance under short-circuit condition	5	10		μ H
L _{Output} (SE)			5	10		
L _{Output} (PBTl)			5	10		
F _{PWM}	PWM frame rate		192	384	432	kHz
T _J	Junction temperature		0		125	°C

AUDIO SPECIFICATIONS (BTL)

PVDD_X = 50 V, GVDD = VDD = 12 V, BTL mode, R_L = 6 Ω , R_{OC} = 22 K Ω , audio frequency = 1 kHz, AES17 filter, F_{PWM} = 384 kHz, case temperature = 75°C, unless otherwise noted. Audio performance is recorded as a chipset, using TAS5508 PWM processor with an effective modulation index limit of 96.1%. All performance is in accordance with recommended operating conditions unless otherwise specified.

PARAMETER		TEST CONDITIONS	TAS5162			UNIT
			MIN	TYP	MAX	
P _O	Power output per channel, DKD package	R _L = 4 Ω, 10% THD, clipped input signal (PVDD = 38.5 Volts)	160			W
		R _L = 6 Ω, 10% THD, clipped input signal	210			
		R _L = 8 Ω, 10% THD, clipped input signal	160			
		R _L = 4 Ω, 0 dBFS, unclipped input signal (PVDD = 38.5 Volts)	120			
		R _L = 6 Ω, 0 dBFS, unclipped input signal	165			
		R _L = 8 Ω, 0 dBFS, unclipped input signal	125			
THD+N	Total harmonic distortion + noise	0 dBFS	0.2%			
		1 W	0.09%			
V _n	Output integrated noise	A-weighted, TAS5508 Modulator	140			μV
		A-Weighted, TAS5518 Modulator	85			
SNR	Signal-to-noise ratio ⁽¹⁾	A-weighted, TAS5508 Modulator	102			dB
		A-weighted, TAS5518 Modulator	112			
DNR	Dynamic range	A-weighted, input level = −60 dBFS using TAS5508 modulator	102			dB
		A-weighted, input level = −60 dBFS using TAS5518 modulator	112			
P _{idle}	Power dissipation due to idle losses (IPVDD_X)	P _O = 0 W, 4 channels switching ⁽²⁾	2.5			W

(1) SNR is calculated relative to 0-dBFS input level.

(2) Actual system idle losses are affected by core losses of output inductors.

AUDIO SPECIFICATIONS (Single-Ended Output)

PVDD_X = 50 V, GVDD = VDD = 12 V, SE mode, R_L = 3 Ω , R_{OC} = 22 K Ω , audio frequency = 1 kHz, AES17 filter, F_{PWM} = 384 kHz, case temperature = 75°C, unless otherwise noted. Audio performance is recorded as a chipset, using TAS5086 PWM processor with an effective modulation index limit of 96.1%. All performance is in accordance with recommended

AUDIO SPECIFICATIONS (Single-Ended Output) (continued)

PVDD_X = 50 V, GVDD = VDD = 12 V, SE mode, $R_L = 3\ \Omega$, $R_{OC} = 22\ \text{K}\Omega$, audio frequency = 1 kHz, AES17 filter, $F_{PWM} = 384\ \text{kHz}$, case temperature = 75°C, unless otherwise noted. Audio performance is recorded as a chipset, using TAS5086 PWM processor with an effective modulation index limit of 96.1%. All performance is in accordance with recommended operating conditions unless otherwise specified.

operating conditions unless otherwise specified.

PARAMETER	TEST CONDITIONS	TAS5162			UNIT
		MIN	TYP	MAX	
P_O Power output per channel, DKD package	$R_L = 3\ \Omega$, 10% THD, clipped input signal		105		W
	$R_L = 4\ \Omega$, 10% THD, clipped input signal		80		
	$R_L = 3\ \Omega$, 0 dBFS, unclipped input signal		80		
	$R_L = 4\ \Omega$, 0 dBFS, unclipped input signal		60		
THD+N Total harmonic distortion + noise	0 dBFS		0.2%		
	1 W		0.09%		
V_n Output integrated noise	A-weighted		85		μV
SNR Signal-to-noise ratio ⁽¹⁾	A-weighted		110		dB
DNR Dynamic range	A-weighted, input level = –60 dBFS using TAS5086 modulator		110		dB
P_{idle} Power dissipation due to idle losses (IPVDD_X)	$P_O = 0\ \text{W}$, 4 channels switching ⁽²⁾		2.5		W

(1) SNR is calculated relative to 0-dBFS input level.

(2) Actual system idle losses are affected by core losses of output inductors.

AUDIO SPECIFICATIONS (PBTL)

PVDD_X = 50 V, GVDD = VDD = 12 V, PBTL mode, $R_L = 4\ \Omega$, $R_{OC} = 22\ \text{K}\Omega$, 1/2 of an MBRM5100-13 dual, 5A@100V, Schottky diode connected from each output pin to ground, audio frequency = 1 kHz, AES17 filter, $F_{PWM} = 384\ \text{kHz}$, case temperature = 75°C, unless otherwise noted. Audio performance is recorded as a chipset, using TAS5508 PWM processor with an effective modulation index limit of 96.1%. All performance is in accordance with recommended operating conditions unless otherwise specified.

PARAMETER	TEST CONDITIONS	TAS5162			UNIT
		MIN	TYP	MAX	
P_O Power output per channel, DKD package	$R_L = 4\ \Omega$, 10% THD, clipped input signal		300		W
	$R_L = 4\ \Omega$, 0 dBFS, unclipped input signal		240		
	$R_L = 3\ \Omega$, 10% THD, clipped input signal		400		
	$R_L = 3\ \Omega$, 0 dBFS, unclipped input signal		300		
THD+N Total harmonic distortion + noise	0 dBFS		0.2%		
	1 W		0.09%		
V_n Output integrated noise	A-weighted		140		μV
SNR Signal-to-noise ratio ⁽¹⁾	A-weighted		102		dB
DNR Dynamic range	A-weighted, input level = –60 dBFS using TAS5508 modulator		102		dB
	A-weighted, input level = –60 dBFS using TAS5518 modulator		110		
P_{idle} Power dissipation due to idle losses (IPVDD_X)	$P_O = 0\ \text{W}$, 1 channel switching ⁽²⁾		2.5		W

(1) SNR is calculated relative to 0-dBFS input level.

(2) Actual system idle losses are affected by core losses of output inductors.

ELECTRICAL CHARACTERISTICS

$R_L = 6\ \Omega$, $F_{PWM} = 384\ \text{kHz}$, unless otherwise noted. All performance is in accordance with recommended operating conditions unless otherwise specified.

PARAMETER		TEST CONDITIONS	TAS5162			UNIT
			MIN	TYP	MAX	
Internal Voltage Regulator and Current Consumption						
VREG	Voltage regulator, only used as a reference node	VDD = 12 V	2.95	3.3	3.65	V
IVDD	VDD supply current	Operating, 50% duty cycle	10			mA
		Idle, reset mode	6			
IGVDD_X	Gate supply current per half-bridge	50% duty cycle	8			mA
		Reset mode	0.3			
IPVDD_X	Half-bridge idle current	50% duty cycle, without output filter or load	15			mA
		Reset mode, no switching	500			µA
Output Stage MOSFETs						
R _{DSon,LS}	Drain-to-source resistance, LS	T _J = 25°C, includes metallization resistance, GVDD = 12 V	90			mΩ
R _{DSon,HS}	Drain-to-source resistance, HS	T _J = 25°C, includes metallization resistance, GVDD = 12 V	90			mΩ
I/O Protection						
V _{uvp,G}	Undervoltage protection limit, GVDD_X		8.5			V
V _{uvp,hyst} ⁽¹⁾			400			mV
OTW ⁽¹⁾	Overtemperature warning		115	125	135	°C
OTW _{HYST} ⁽¹⁾	Temperature drop needed below OTW temp. for OTW to be inactive after the OTW event		25			°C
OTE ⁽¹⁾	Overtemperature error		145	155	165	°C
OTE-OTW _{differential} ⁽¹⁾	OTE-OTW differential		25			°C
OTE _{HYST} ⁽¹⁾	A reset needs to occur for \overline{SD} for be released following an OTE event.		25			°C
OLPC	Overload protection counter	F _{PWM} = 384 kHz	1.3			ms
I _{OC}	Overcurrent limit protection	Resistor—programmable, nominal, R _{OCP} = 22 kΩ	12			A
I _{OCT}	Overcurrent response time	Time from application of short condition to Hi-Z of affected 1/2 bridge	250			ns
R _{OCP}	OC programming resistor range	Resistor tolerance = 5%	22	69		kΩ
R _{PD}	Internal pulldown resistor at the output of each half-bridge	Connected when \overline{RESET} is active to provide bootstrap capacitor charge. Not used in SE mode	1.0			kΩ
Static Digital Specifications						
V _{IH}	High-level input voltage	PWM_A, PWM_B, PWM_C, PWM_D, M1, M2, M3, $\overline{RESET_AB}$, $\overline{RESET_CD}$	2			V
V _{IL}	Low-level input voltage		0.8		V	
Leakage	Input leakage current		-100	100		µA
OTW/SHUTDOWN (SD)						
R _{INT_PU}	Internal pullup resistance, \overline{OTW} to VREG, \overline{SD} to VREG		20	26	35	kΩ
V _{OH}	High-level output voltage	Internal pullup resistor	2.95	3.3	3.65	V
		External pullup of 4.7 kΩ to 5 V	4.5	5		
V _{OL}	Low-level output voltage	I _O = 4 mA	0.2		0.4	V
FANOUT	Device fanout \overline{OTW} , \overline{SD}	No external pullup	30			Devices

(1) Specified by design

TYPICAL CHARACTERISTICS, BTL CONFIGURATION

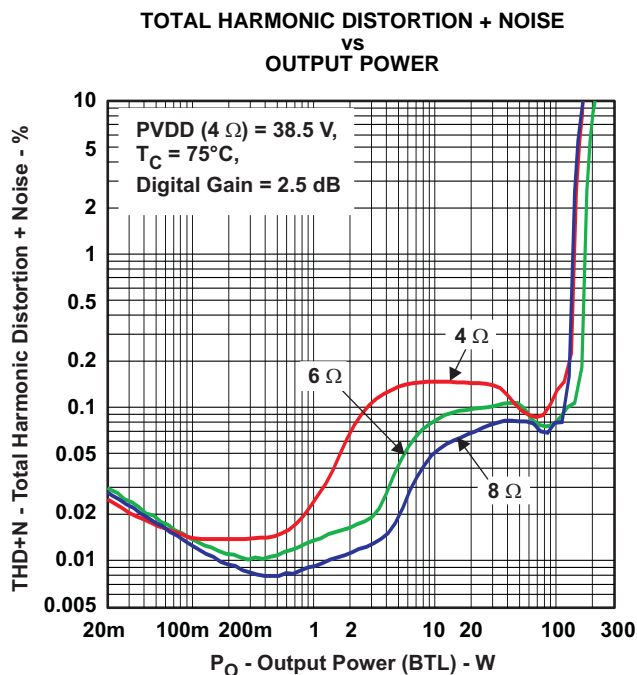


Figure 1.

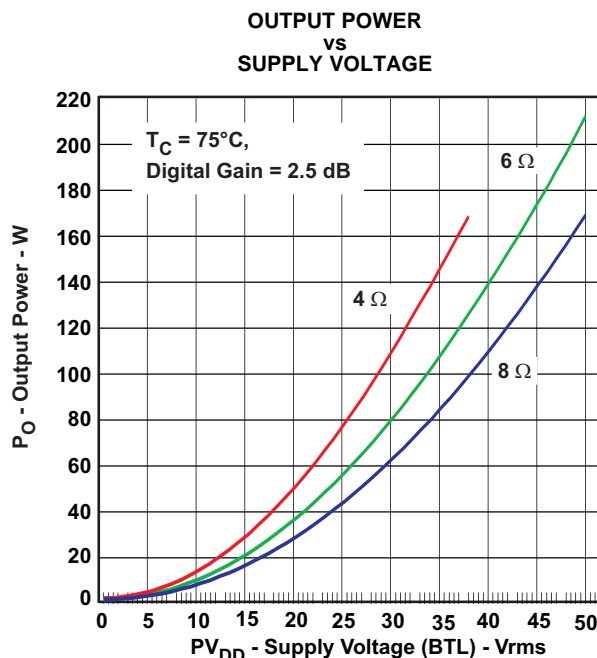


Figure 2.

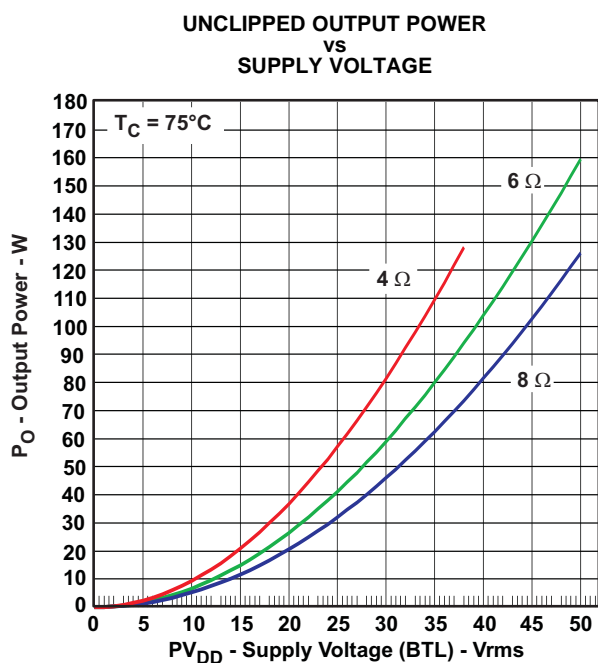


Figure 3.

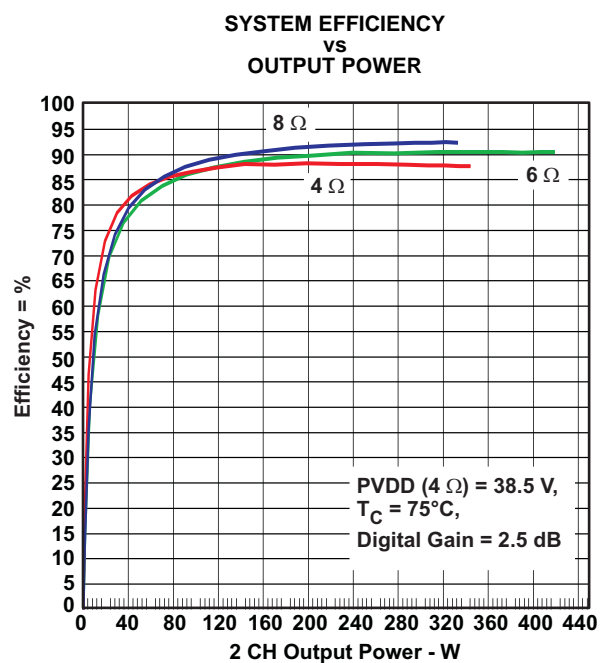


Figure 4.

TYPICAL CHARACTERISTICS, BTL CONFIGURATION (continued)

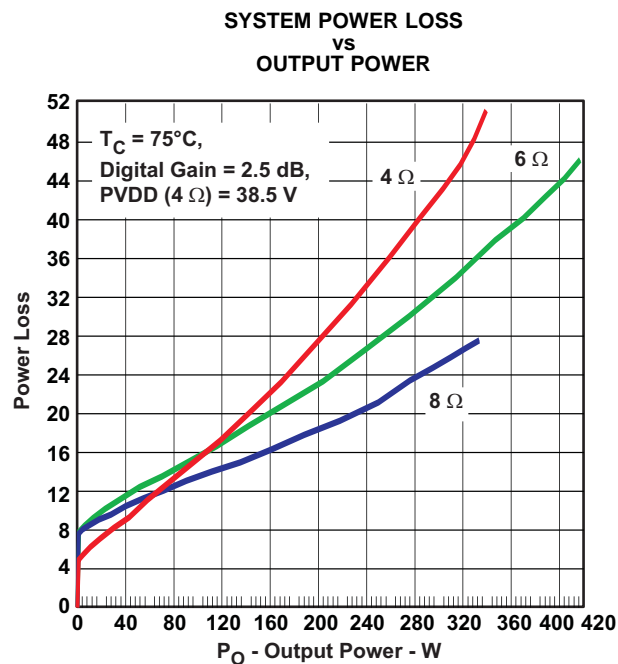


Figure 5.

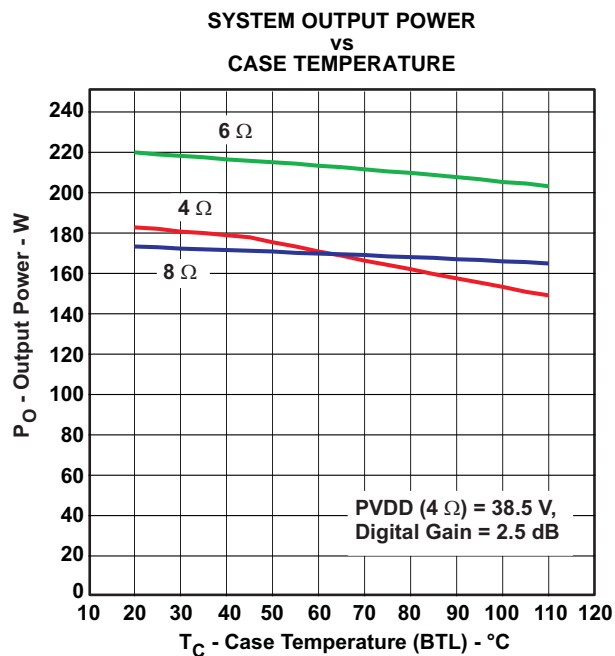


Figure 6.

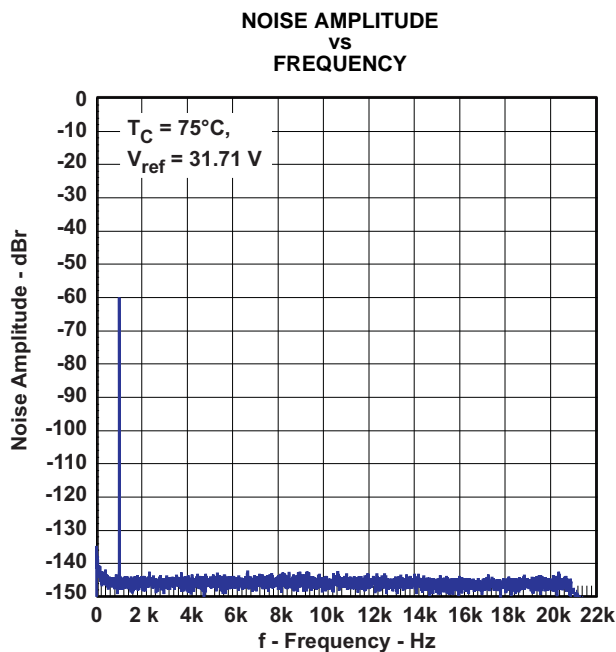


Figure 7.

TYPICAL CHARACTERISTICS, SE CONFIGURATION

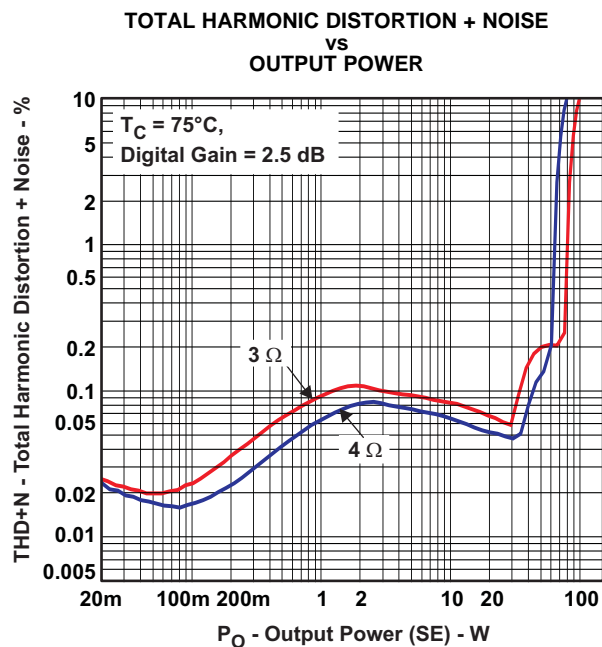


Figure 8.

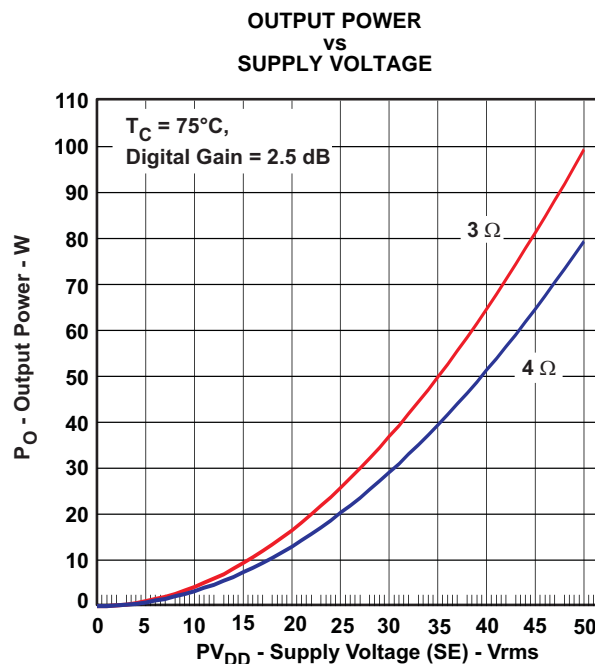


Figure 9.

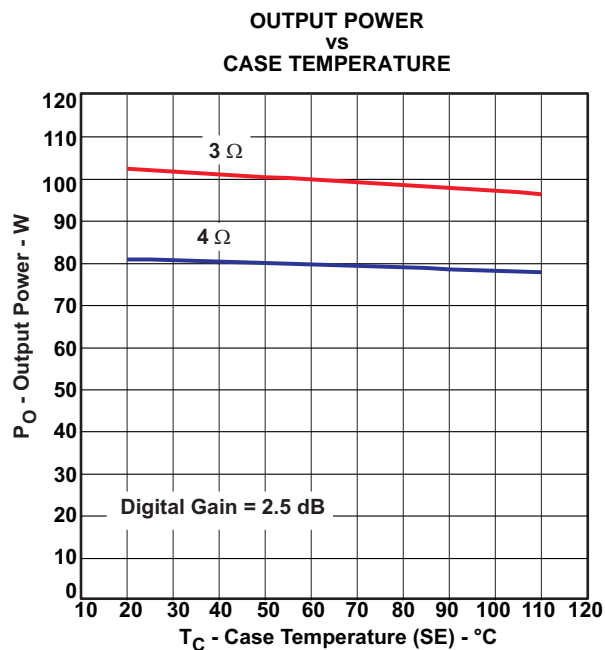


Figure 10.

TYPICAL CHARACTERISTICS, PBTL CONFIGURATION

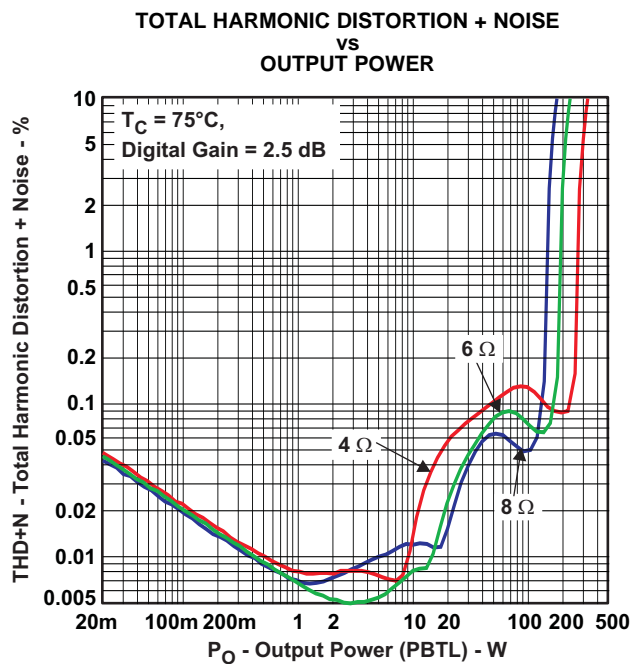


Figure 11.

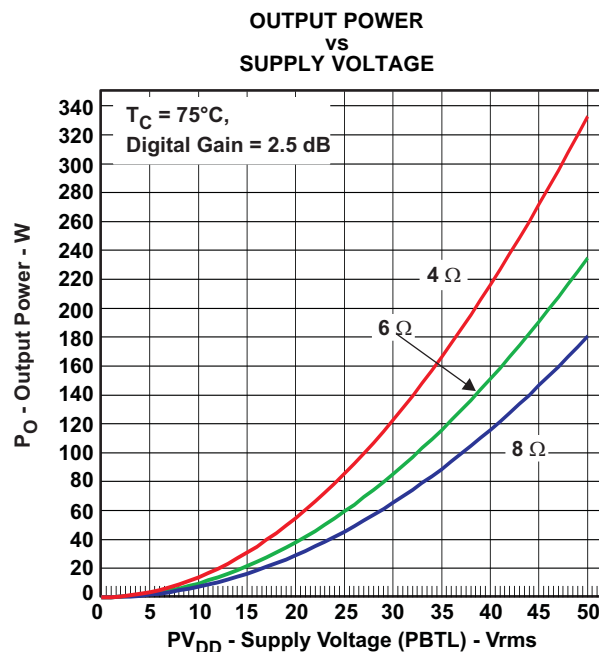


Figure 12.

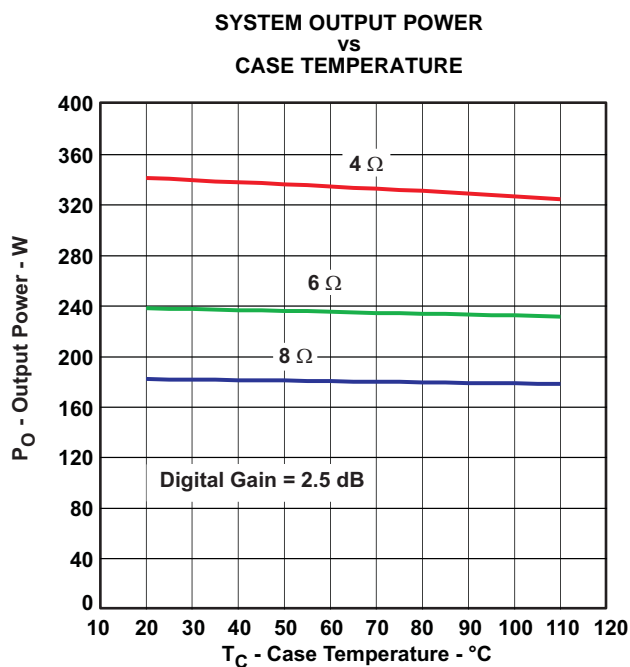
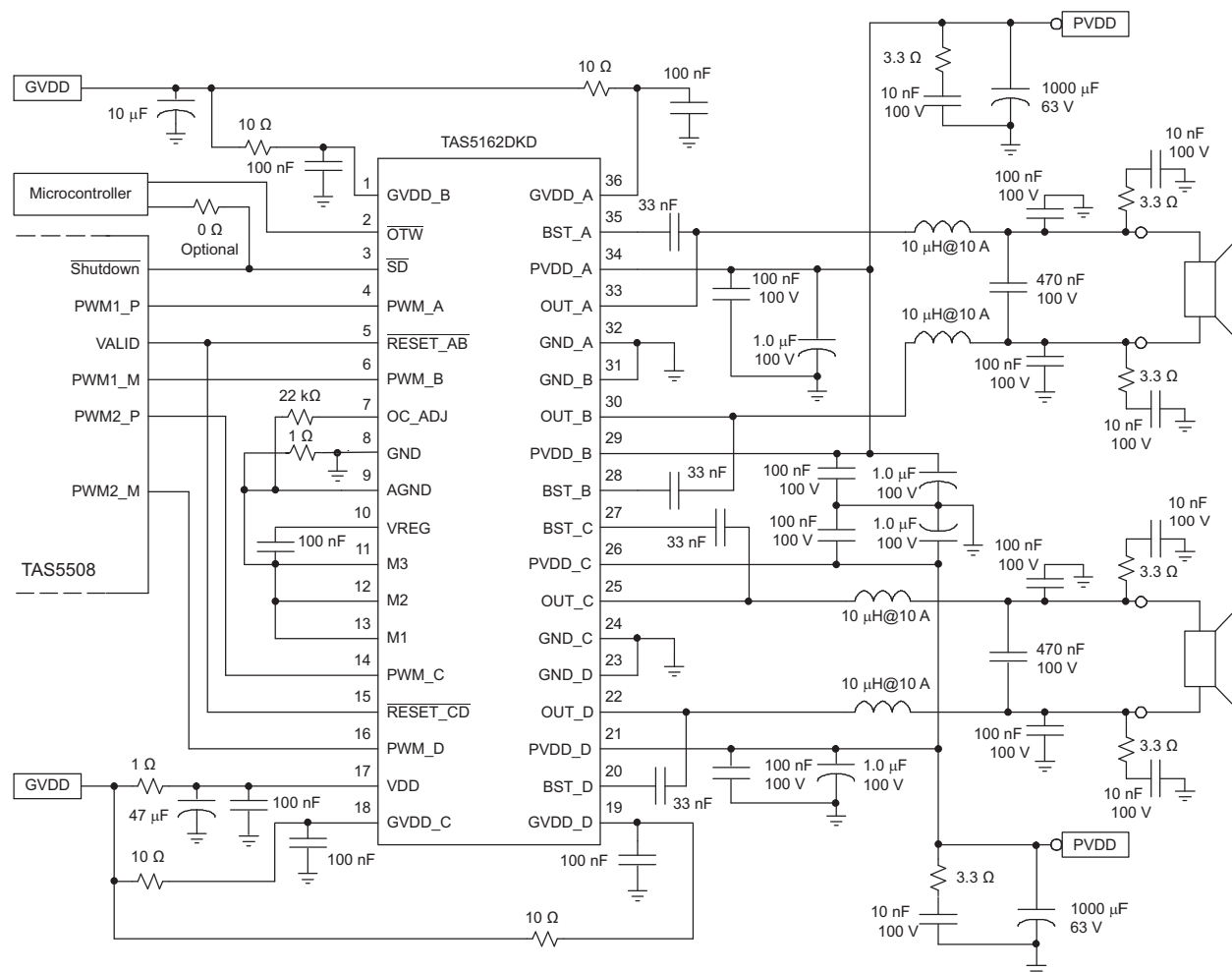


Figure 13.



ai_d_btl_les194

Figure 14. Typical Differential (2N) BTL Application With AD Modulation Filters (For Reference Only, component values and connection will change.)



16

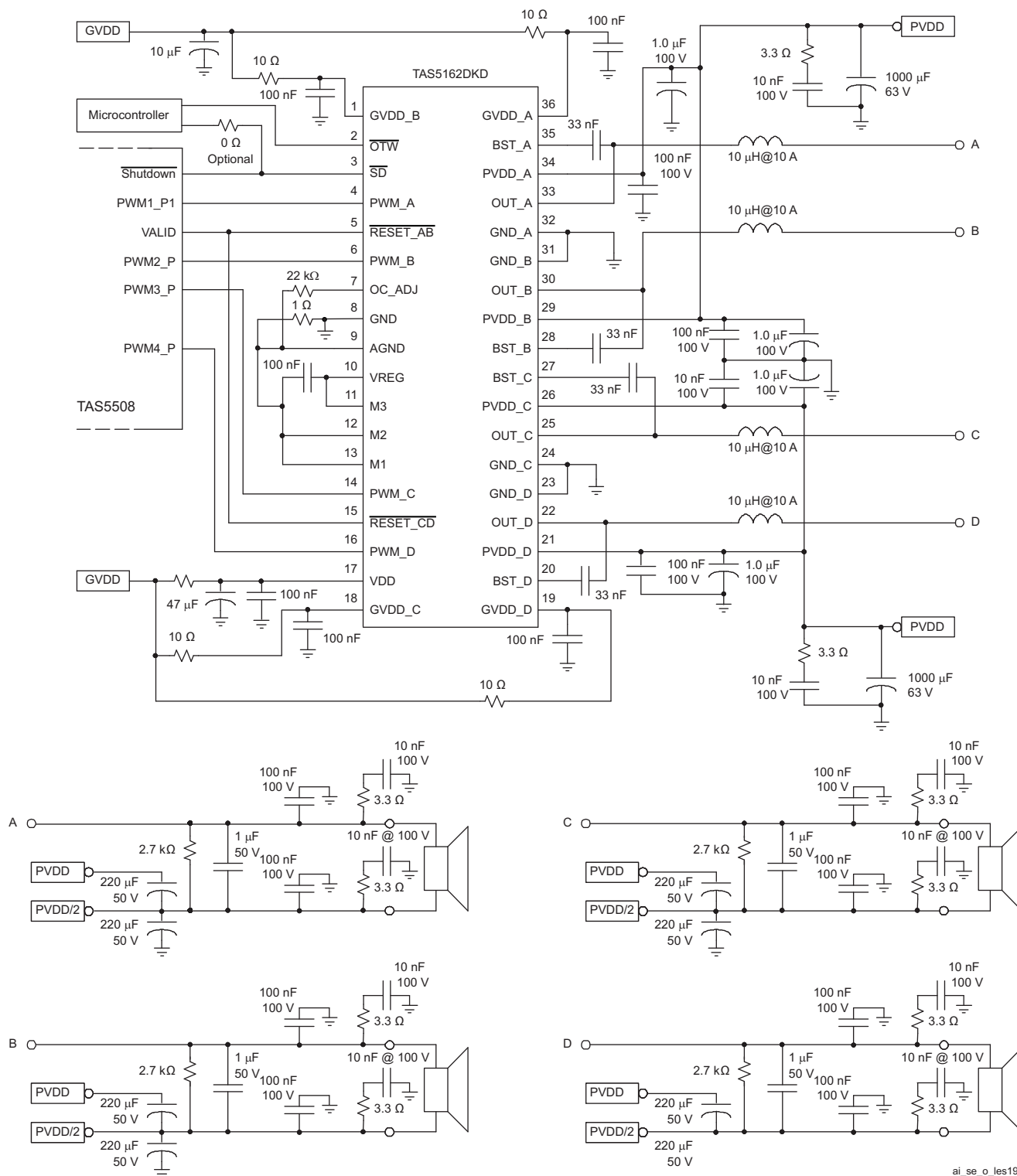
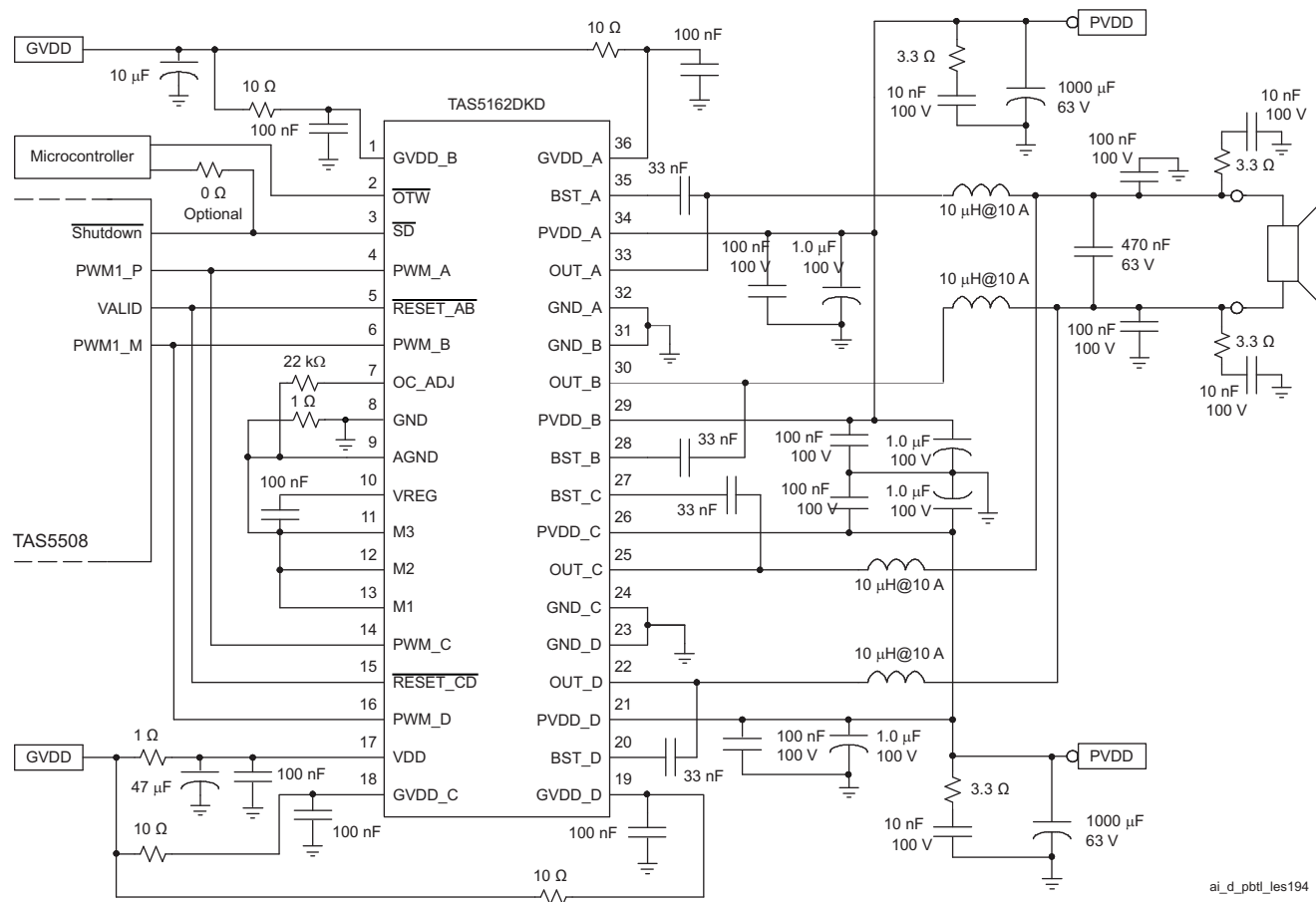
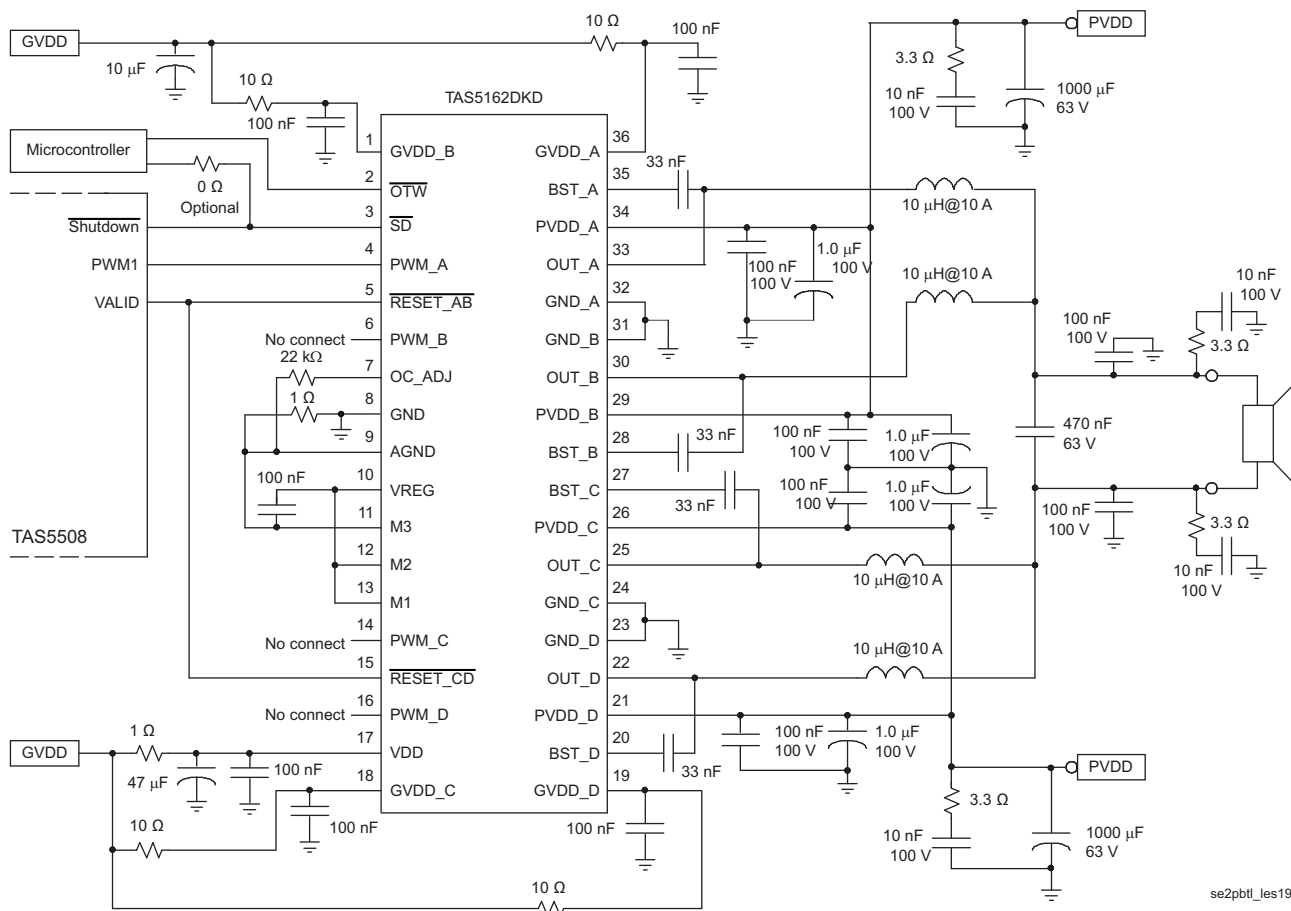


Figure 16. Typical SE Application (For Reference Only, component values and connection will change.)



ai_d_pbtl_les194

Figure 17. Typical Differential (2N) PBTL Application With AD Modulation Filters (For Reference Only, component values and connection will change.)



se2pbt1_les194

Figure 18. Typical Non-Differential (1N) PBTL Application (For Reference Only, component values and connection will change.)

THEORY OF OPERATION

POWER SUPPLIES

To facilitate system design, the TAS5162 needs only a 12-V supply in addition to the (typical) 50-V power-stage supply. An internal voltage regulator provides suitable voltage levels for the digital and low-voltage analog circuitry. Additionally, all circuitry requiring a floating voltage supply, e.g., the high-side gate drive, is accommodated by built-in bootstrap circuitry requiring only a few external capacitors.

In order to provide outstanding electrical and acoustical characteristics, the PWM signal path including gate drive and output stage is designed as identical, independent half-bridges. For this reason, each half-bridge has separate gate drive supply (GVDD_X), bootstrap pins (BST_X), and power-stage supply pins (PVDD_X). Furthermore, an additional pin (VDD) is provided as supply for all common circuits. Although supplied from the same 12-V source, it is highly recommended to separate GVDD_A, GVDD_B, GVDD_C, GVDD_D, and VDD on the printed-circuit board (PCB) by RC filters (see application diagram for details). These RC filters provide the recommended high-frequency isolation. Special attention should be paid to placing all decoupling capacitors as close to their associated pins as possible. In general, inductance between the power supply pins and decoupling capacitors must be avoided. (See reference board documentation for additional information.)

For a properly functioning bootstrap circuit, a small ceramic capacitor must be connected from each bootstrap pin (BST_X) to the power-stage output pin (OUT_X). When the power-stage output is low, the bootstrap capacitor is charged through an internal diode connected between the gate-drive power-supply pin (GVDD_X) and the bootstrap pin. When the power-stage output is high, the bootstrap capacitor potential is shifted above the output potential and thus provides a suitable voltage supply for the high-side gate driver. In an application with PWM switching frequencies in the range from 352 kHz to 384 kHz, it is recommended to use 33-nF ceramic capacitors, size 0603 or 0805, for the bootstrap supply. These 33-nF capacitors ensure sufficient energy storage, even during minimal PWM duty cycles, to keep the high-side power stage FET (LDMOS) fully turned on during the remaining part of the PWM cycle. In an application running at a reduced switching frequency, generally 192 kHz, the bootstrap capacitor might need to be increased in value.

Special attention should be paid to the power-stage power supply; this includes component selection, PCB placement, and routing. As indicated, each half-bridge has independent power-stage supply pins (PVDD_X). For optimal electrical performance, EMI compliance, and system reliability, it is important that each PVDD_X pin is decoupled with a 100-nF ceramic capacitor placed as close as possible to each supply pin. It is recommended to follow the PCB layout of the TAS5162 reference design. For additional information on recommended power supply and required components, see the application diagrams given previously in this data sheet.

The 12-V supply should be from a low-noise, low-output-impedance voltage regulator. Likewise, the 50-V power-stage supply is assumed to have low output impedance and low noise. The power-supply sequence is not critical as facilitated by the internal power-on-reset circuit. Moreover, the TAS5162 is fully protected against erroneous power-stage turn-on due to parasitic gate charging. Thus, voltage-supply ramp rates (dV/dt) are non-critical within the specified range (see the *Recommended Operating Conditions* section of this data sheet).

SYSTEM POWER-UP/POWER-DOWN SEQUENCE

Powering Up

The TAS5162 does not require a power-up sequence. The outputs of the H-bridges remain in a high-impedance state until the gate-drive supply voltage (GVDD_X) and VDD voltage are above the undervoltage protection (UVP) voltage threshold (see the *Electrical Characteristics* section of this data sheet). Although not specifically required, it is recommended to hold RESET_AB and RESET_CD in a low state while powering up the device. This allows an internal circuit to charge the external bootstrap capacitors by enabling a weak pulldown of the half-bridge output.

When the TAS5162 is being used with TI PWM modulators such as the TAS5508, no special attention to the state of RESET_AB and RESET_CD is required, provided that the chipset is configured as recommended.

Powering Down

The TAS5162 does not require a power-down sequence. The device remains fully operational as long as the gate-drive supply (GVDD_X) voltage and VDD voltage are above the undervoltage protection (UVP) voltage threshold (see the *Electrical*

Characteristics section of this data sheet). Although not specifically required, it is a good practice to hold RESET_AB and RESET_CD low during power down, thus preventing audible artifacts including pops or clicks.

When the TAS5162 is being used with TI PWM modulators such as the TAS5508, no special attention to the state of RESET_AB and RESET_CD is required, provided that the chipset is configured as recommended.

Mid Z Sequence Compatibility

The TAS5162 is compatible with the Mid Z Sequence from the TAS5086 Modulator. The Mid Z Sequence is a series of pulses that is generated by the modulator that causes the power stage to slowly enable its outputs as it begins to switch.

By slowly starting the PWM switching, the impulse response created by the onset of switching is reduced. This impulse response is the acoustic artifact that is heard in the output transducers (loudspeakers) and is commonly termed a "click" or "pop".

The low acoustic artifact noise of TAS5162 will be further decreased when used in combination with a TAS5086 modulator and the Mid Z sequence is enabled.

The Mid Z Sequence is primarily used for the single-ended mode of operation. It facilitates a "softer" PWM output start after the split cap output configuration is charged.

ERROR REPORTING

The SD and OTW pins are both active-low, open-drain outputs. Their function is for protection-mode signaling to a PWM controller or other system-control device.

Any fault resulting in device shutdown is signaled by the SD pin going low. Likewise, OTW goes low when the device junction temperature exceeds 125°C (see the following table).

<u>SD</u>	<u>OTW</u>	DESCRIPTION
0	0	Overtemperature (OTE) or overload (OLP) or undervoltage (UVP)
0	1	Overload (OLP) or undervoltage (UVP)
1	0	Junction temperature higher than 125°C (overtemperature warning)
1	1	Junction temperature lower than 125°C and no OLP or UVP faults (normal operation)

Note that asserting either RESET_AB or RESET_CD low forces the SD signal high, independent of faults

being present. TI recommends monitoring the OTW signal using the system microcontroller and responding to an overtemperature warning signal by, e.g., turning down the volume to prevent further heating of the device resulting in device shutdown (OTE).

To reduce external component count, an internal pullup resistor to 3.3 V is provided on both SD and OTW outputs. Level compliance for 5-V logic can be obtained by adding external pullup resistors to 5 V (see the *Electrical Characteristics* section of this data sheet for further specifications).

DEVICE PROTECTION SYSTEM

The TAS5162 contains advanced protection circuitry carefully designed to facilitate system integration and ease of use, as well as to safeguard the device from permanent failure due to a wide range of fault conditions such as short circuits, overload, overtemperature, and undervoltage. The TAS5162 responds to a fault by immediately setting the power stage in a high-impedance (Hi-Z) state and asserting the SD pin low. In situations other than overload or over temperature, the device automatically recovers when the fault condition has been removed or the gate supply voltage has increased. For highest possible reliability, recovering from an overload/over-temperature fault requires external reset of the device (see the *Device Reset* section of this data sheet) no sooner than 1 second after the shutdown.

The TAS5162 contains circuitry associated with its PWM inputs that will detect the condition when a PWM input is continuously high or low. Without this protection circuitry, if a PWM input is not correct, the PVDD power supply could appear on the associated output pin. This condition could damage either the output load (loudspeaker) or the device. If a PWM input remains either high or low over 15µs, the device's outputs will be set into a Hi-Z state. If this error condition occurs, SD will not be asserted low.

The above mentioned operation is used for all of the BTL output modes except for Mode 0,0,1 and the Single-ended Mode 1,0,1 those are the Latching Shutdown Modes. In the Latching Shutdown Mode, the over current error recovery circuitry is disabled and an over current condition will cause the device to shutdown immediately. After shutdown, RESET_AB and/or RESET_CD must be asserted to restore normal operation after the over current condition is removed.

Use of TAS5162 in High-Modulation-Index Capable Systems

This device requires at least 50 ns of low time on the output per 384-kHz PWM frame rate in order to keep the bootstrap capacitors charged. As an example, if the modulation index is set to 99.2% in the TAS5508, this setting allows PWM pulse durations down to 20 ns. This signal, which does not meet the 50-ns requirement, is sent to the PWM_X pin and this low-state pulse time does not allow the bootstrap capacitor to stay charged. In this situation, the low voltage across the bootstrap capacitor can cause a failure of the high-side MOSFET transistor, especially when driving a low-impedance load. The TAS5162 device requires limiting the TAS5508 modulation index to less than 97.0% to keep the bootstrap capacitor charged under all signals and loads.

The device contains bootstrap capacitor under voltage protection circuit (BST_UVP) that monitors the voltage on the bootstrap capacitors. When the voltage on the on the bootstrap capacitors is less than required for safe operation, the TAS5162 will initiate bootstrap capacitor recharge sequences until the bootstrap capacitors are properly charged for safe operation. This function may be activated at a modulation index of greater than 97.0%.

TI strongly recommends using a TI PWM processor, such as TAS5508 or TAS5086, with the modulation index set at 96.1% to interface with TAS5162.

The Modulation Index is set by writing 0x04 to the Modulation Index Limit Register (0x16) in the TAS5508B or TAS5518A. In the case of the TAS5086 a 0x04 is written to the Modulation Limit Register (0x10).

Overcurrent (OC) Protection With Current Limiting and Overload Detection

The device has independent, fast-reacting current detectors with programmable trip threshold (OC threshold) on all high-side and low-side power-stage FETs. See the following table for OC-adjust resistor values. The detector outputs are closely monitored by two protection systems. The first protection system controls the power stage in order to prevent the output current from further increasing, i.e., it performs a current-limiting function rather than prematurely shutting down during combinations of high-level music transients and extreme speaker load impedance drops. If the high-current situation persists, i.e., the power stage is being overloaded, a second protection system triggers a latching shutdown, resulting in the power stage being set in the high-impedance (Hi-Z) state. Current limiting and

overload protection are independent for half-bridges A and B and, respectively, C and D. That is, if the bridge-tied load between half-bridges A and B causes an overload fault, only half-bridges A and B are shut down.

- For the lowest-cost bill of materials in terms of component selection, the OC threshold measure should be limited, considering the power output requirement and minimum load impedance. Higher-impedance loads require a lower OC threshold.
- The demodulation-filter inductor must retain at least 5 μ H of inductance at twice the OC threshold setting.

Unfortunately, most inductors have decreasing inductance with increasing temperature and increasing current (saturation). To some degree, an increase in temperature naturally occurs when operating at high output currents, due to core losses and the dc resistance of the inductor's copper winding. A thorough analysis of inductor saturation and thermal properties is strongly recommended.

Setting the OC threshold too low might cause issues such as lack of enough output power and/or unexpected shutdowns due to too-sensitive overload detection.

In general, it is recommended to follow closely the external component selection and PCB layout as given in the *Application* section.

For added flexibility, the OC threshold is programmable within a limited range using a single external resistor connected between the OC_ADJ pin and AGND. (See the *Electrical Characteristics* section of this data sheet for information on the correlation between programming-resistor value and the OC threshold.) It should be noted that a properly functioning overcurrent detector assumes the presence of a properly designed demodulation filter at the power-stage output. Short-circuit protection is not provided directly at the output pins of the power stage but only on the speaker terminals (after the demodulation filter). It is required to follow certain guidelines when selecting the OC threshold and an appropriate demodulation inductor:

OC-Adjust Resistor Values (k Ω)	Max. Current Before OC Occurs (A)
22	12.2
27	10.5
47	6.4
68	4.0
100	3.0

Overtemperature Protection

The TAS5162 has a two-level temperature-protection

system that asserts an active-low warning signal ($\overline{\text{OTW}}$) when the device junction temperature exceeds 125°C (nominal) and, if the device junction temperature exceeds 155°C (nominal), the device is put into thermal shutdown, resulting in all half-bridge outputs being set in the high-impedance (Hi-Z) state and $\overline{\text{SD}}$ being asserted low. OTE is latched in this case and $\overline{\text{RESET_AB}}$ and $\overline{\text{RESET_CD}}$ must be asserted low.

Undervoltage Protection (UVP) and Power-On Reset (POR)

The UVP and POR circuits of the TAS5162 fully protect the device in any power-up/down and brownout situation. While powering up, the POR circuit resets the overload circuit (OLP) and ensures that all circuits are fully operational when the GVDD_X and VDD supply voltages reach 9.8 V (typical). Although GVDD_X and VDD are independently monitored, a supply voltage drop below the UVP threshold on any VDD or GVDD_X pin results in all half-bridge outputs immediately being set in the high-impedance (Hi-Z) state and $\overline{\text{SD}}$ being asserted low. The device automatically resumes operation when all supply voltage on the bootstrap capacitors have increased above the UVP threshold.

DEVICE RESET

Two reset pins are provided for independent control of half-bridges A/B and C/D. When $\overline{\text{RESET_AB}}$ is asserted low, all four power-stage FETs in half-bridges A and B are forced into a high-impedance (Hi-Z) state. Likewise, asserting $\overline{\text{RESET_CD}}$ low forces all four power-stage FETs in half-bridges C and D into a high-impedance state. Thus, both reset pins are well suited for hard-muting the power stage if needed.

In BTL modes, to accommodate bootstrap charging prior to switching start, asserting the reset inputs low enables weak pulldown of the half-bridge outputs. In the SE mode, the weak pulldowns are not enabled, and it is therefore recommended to ensure bootstrap capacitor charging by providing a low pulse on the PWM inputs when reset is asserted high.

Asserting either reset input low removes any fault information to be signaled on the $\overline{\text{SD}}$ output, i.e., $\overline{\text{SD}}$ is forced high.

A rising-edge transition on either reset input allows the device to resume operation after an overload fault.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TAS5162DDV	ACTIVE	HTSSOP	DDV	44	35	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	0 to 70	TAS5162	Samples
TAS5162DDVG4	ACTIVE	HTSSOP	DDV	44	35	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	0 to 70	TAS5162	Samples
TAS5162DDVR	ACTIVE	HTSSOP	DDV	44	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	0 to 70	TAS5162	Samples
TAS5162DDVRG4	ACTIVE	HTSSOP	DDV	44	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	0 to 70	TAS5162	Samples
TAS5162DKD	ACTIVE	HSSOP	DKD	36	29	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-4-260C-72 HR	0 to 70	TAS5162	Samples
TAS5162DKDG4	ACTIVE	HSSOP	DKD	36	29	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-4-260C-72 HR	0 to 70	TAS5162	Samples
TAS5162DKDR	ACTIVE	HSSOP	DKD	36	500	Green (RoHS & no Sb/Br)	NIPDAU CU NIPDAU	Level-4-260C-72 HR	0 to 70	TAS5162	Samples
TAS5162DKDRG4	ACTIVE	HSSOP	DKD	36	500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-4-260C-72 HR	0 to 70	TAS5162	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TAS5162DDVR	HTSSOP	DDV	44	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
TAS5162DKDR	HSSOP	DKD	36	500	330.0	24.4	14.7	16.4	4.0	20.0	24.0	Q1

TAPE AND REEL BOX DIMENSIONS

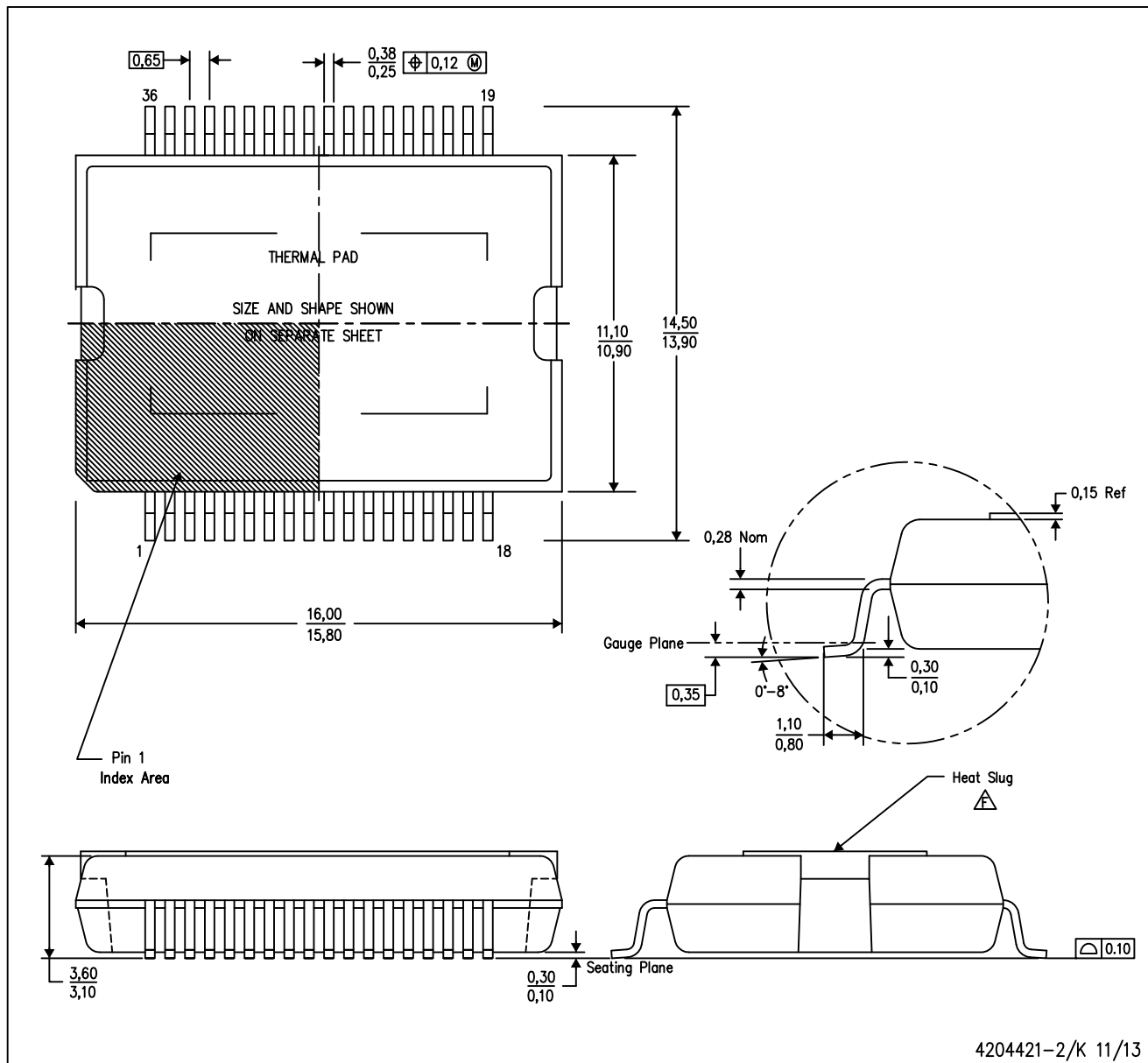


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TAS5162DDVR	HTSSOP	DDV	44	2000	367.0	367.0	45.0
TAS5162DKDR	HSSOP	DKD	36	500	367.0	367.0	45.0

DKD (R-PDSO-G36)

PowerPAD™ PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - Body dimensions do not include mold flash or protrusion not to exceed 0.15mm.
 - This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <<http://www.ti.com>>.
 - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- ⚠ The package thermal performance is optimized for conductive cooling with attachment to an external heat sink.

PowerPAD is a trademark of Texas Instruments.

THERMAL PAD MECHANICAL DATA

DKD (R-PDSO-G36)

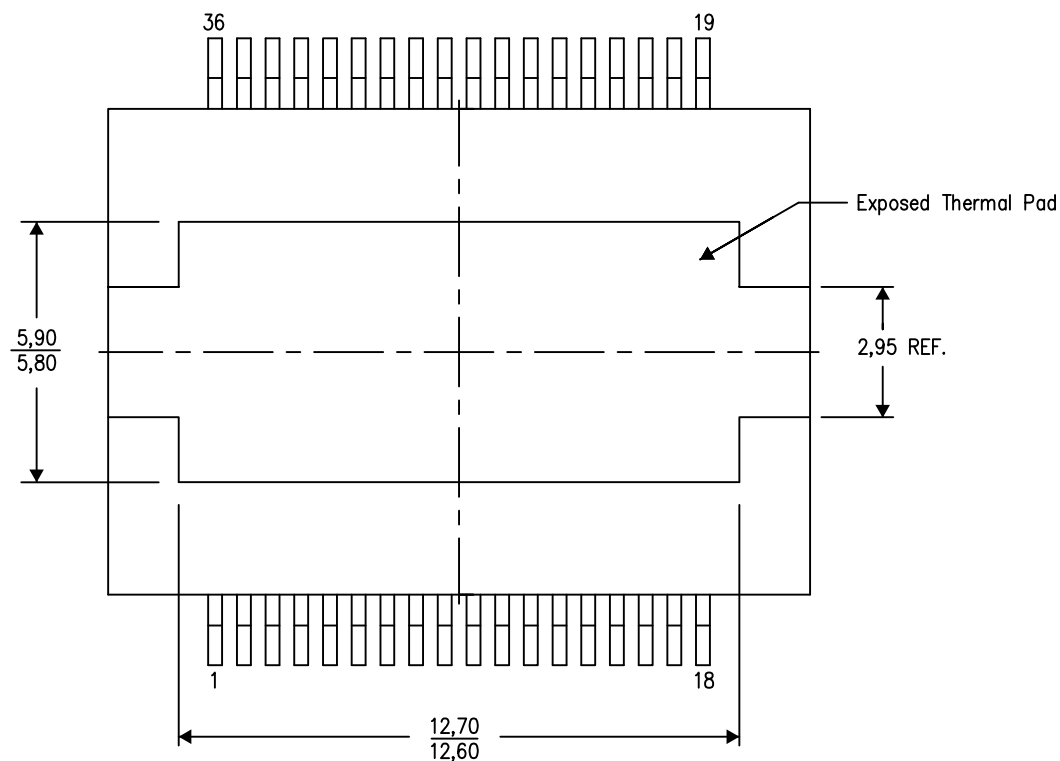
PowerPAD™ PLASTIC SMALL OUTLINE

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

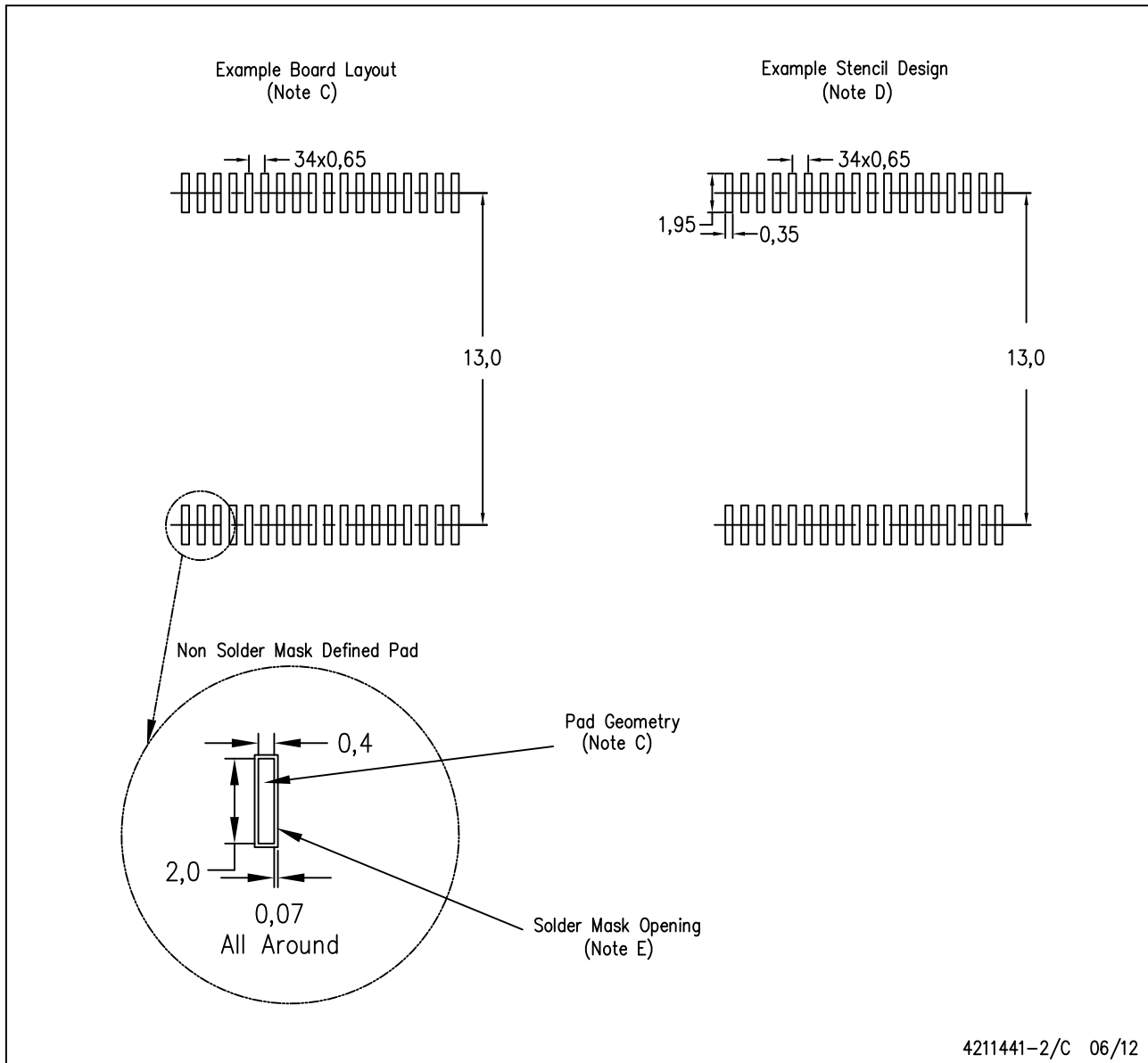


4210894-2/E 06/12

NOTE: All linear dimensions are in millimeters

DKD (R-PDSO-G36)

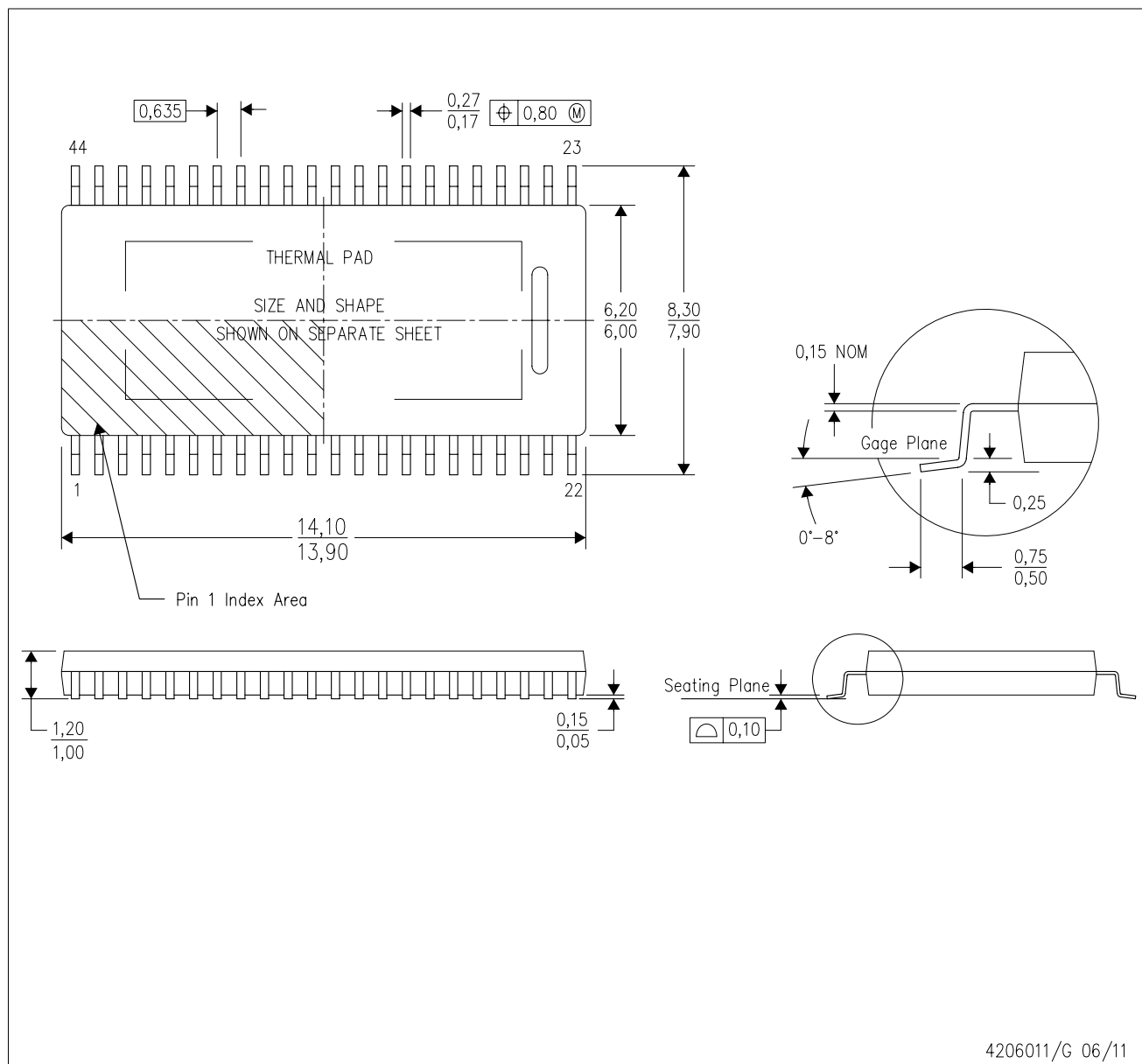
PowerPAD™ PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525.
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

MECHANICAL DATA

DDV (R-PDSO-G44) PowerPAD™ PLASTIC SMALL OUTLINE PACKAGE (DIE DOWN)



- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - Body dimensions do not include mold flash or protrusion not to exceed 0,15.
 - This package is designed to be attached directly to an external heatsink. Refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <<http://www.ti.com>>. See the product data sheet for details regarding the exposed thermal pad dimensions.

PowerPAD is a trademark of Texas Instruments.

DDV (R-PDSO-G44)

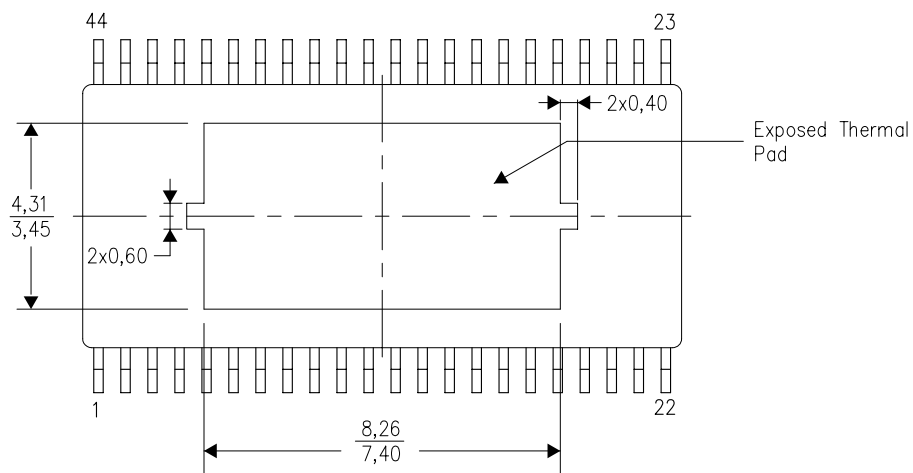
PowerPAD™ SMALL OUTLINE PACKAGE

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Top View

Exposed Thermal Pad Dimensions

4206975-4/D 07/11

NOTE: All linear dimensions are in millimeters

PowerPAD is a trademark of Texas Instruments

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products

Audio	www.ti.com/audio
Amplifiers	amplifier.ti.com
Data Converters	dataconverter.ti.com
DLP® Products	www.dlp.com
DSP	dsp.ti.com
Clocks and Timers	www.ti.com/clocks
Interface	interface.ti.com
Logic	logic.ti.com
Power Mgmt	power.ti.com
Microcontrollers	microcontroller.ti.com
RFID	www.ti-rfid.com
OMAP Applications Processors	www.ti.com/omap
Wireless Connectivity	www.ti.com/wirelessconnectivity

Applications

Automotive and Transportation	www.ti.com/automotive
Communications and Telecom	www.ti.com/communications
Computers and Peripherals	www.ti.com/computers
Consumer Electronics	www.ti.com/consumer-apps
Energy and Lighting	www.ti.com/energy
Industrial	www.ti.com/industrial
Medical	www.ti.com/medical
Security	www.ti.com/security
Space, Avionics and Defense	www.ti.com/space-avionics-defense
Video and Imaging	www.ti.com/video

TI E2E Community

e2e.ti.com